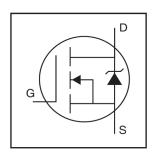
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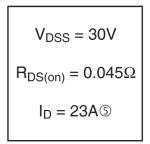
IRLR/U2703PbF

HEXFET® Power MOSFET



- Logic-Level Gate Drive
- Ultra Low On-Resistance
- Surface Mount (IRLR2703)
- Straight Lead (IRLU2703)
- Advanced Process Technology
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

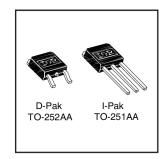




Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The D-PAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.



Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	23 ⑤	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	16	A
I _{DM}	Pulsed Drain Current ①	96	
P _D @T _C = 25°C	Power Dissipation	45	W
	Linear Derating Factor	0.30	W/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy®	77	mJ
I _{AR}	Avalanche Current①	14	A
E _{AR}	Repetitive Avalanche Energy①	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		3.3	
$R_{\theta JA}$	Case-to-Ambient (PCB mount)**		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

^{**} When mounted on 1" square PCB (FR-4 or G-10 Material) . For recommended footprint and soldering techniques refer to application note #AN-994

IRLR/U2703PbF

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	30			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.030		V/°C	Reference to 25°C, I _D = 1mA
	Olafia Busia la Osama Osa Basialana			0.045	Ω	V _{GS} = 10V, I _D = 14A ④
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.065	52	V _{GS} = 4.5V, I _D = 12A ④
V _{GS(th)}	Gate Threshold Voltage	1.0			V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
9fs	Forward Transconductance	6.4			S	V _{DS} = 25V, I _D = 14A⑦
1	Drain to Course Leekage Current			25		$V_{DS} = 30V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100		V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -16V
Qg	Total Gate Charge			15		I _D = 14A
Q _{gs}	Gate-to-Source Charge			4.6	nC	$V_{DS} = 24V$
Q _{gd}	Gate-to-Drain ("Miller") Charge			9.3		V _{GS} = 4.5V, See Fig. 6 and 13 ⊕ ⑦
t _{d(on)}	Turn-On Delay Time		8.5			$V_{DD} = 15V$
t _r	Rise Time		140		ns	$I_D = 14A$
t _{d(off)}	Turn-Off Delay Time		12		115	$R_G = 12\Omega$, $V_{GS} = 4.5V$
t _f	Fall Time		20			$R_D = 1.0\Omega$, See Fig. 10 $\textcircled{9}$
	Internal Drain Inductance	_	4.5		nH	Between lead,
L_D						6mm (0.25in.)
L _S	Internal Source Inductance		7.5		1	from package
						and center of die contact®
C _{iss}	Input Capacitance		450			$V_{GS} = 0V$
Coss	Output Capacitance		210		pF	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		110		1	f = 1.0MHz, See Fig. 5⑦

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions			
Is	Continuous Source Current			00.0		MOSFET symbol			
	(Body Diode)		23 ⑤	(5) A	showing the				
I _{SM}	Pulsed Source Current		!		-00	-00	00		integral reverse
	(Body Diode) ①			96		p-n junction diode.			
V_{SD}	Diode Forward Voltage			1.3	٧	$T_J = 25^{\circ}C$, $I_S = 14A$, $V_{GS} = 0V$ ④			
t _{rr}	Reverse Recovery Time		65	97	ns	$T_J = 25^{\circ}C, I_F = 14A$			
Q _{rr}	Reverse RecoveryCharge		140	210	nC	di/dt = 100A/µs ④⑦			
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)							

Notes:

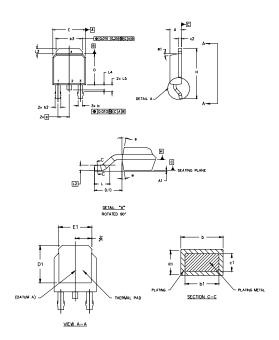
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11) $V_{DD} = 15V$, starting $T_{J} = 25^{\circ}C$, $L = 570 \mu H$
- $R_G = 25\Omega$, $I_{AS} = 14A$. (See Figure 12)
- $\ensuremath{ \Im \ } I_{SD} \leq 14A, \ di/dt \leq 140A/\mu s, \ V_{DD} \leq V_{(BR)DSS},$ $T_J \le 175^{\circ}C$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- ⑤ Caculated continuous current based on maximum allowable junction temperature; Package limitation current = 20A.
- 6 This is applied for I-PAK, L_S of D-PAK is measured between lead and center of die contact.
- ① Uses IRL2703 data and test conditions.

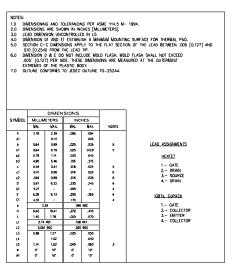
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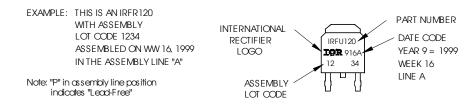
D-Pak (TO-252AA) Package Outline

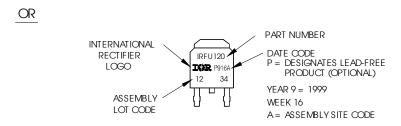
Dimensions are shown in millimeters (inches)





D-Pak (TO-252AA) Part Marking Information





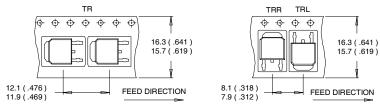
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IRLR/U2703PbF

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D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)

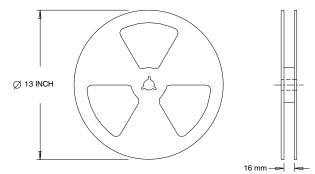


- NOTES:

 1. CONTROLLING DIMENSION: MILLIMETER.

 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).

 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:
1. OUTLINE CONFORMS TO EIA-481.

Data and specifications subject to change without notice.

International IOR Rectifier